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Details	
Product Status	Obsolete
Core Processor	HCS12
Core Size	16-Bit
Speed	25MHz
Connectivity	CANbus, EBI/EMI, SCI, SPI
Peripherals	POR, PWM, WDT
Number of I/O	60
Program Memory Size	96KB (96K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	2.35V ~ 5.5V
Data Converters	A/D 8x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	80-QFP
Supplier Device Package	80-QFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mc9s12c96cfuer

2.3.2.3.6 Port M Polarity Select Register (PPSM)

Module Base + 0x0015

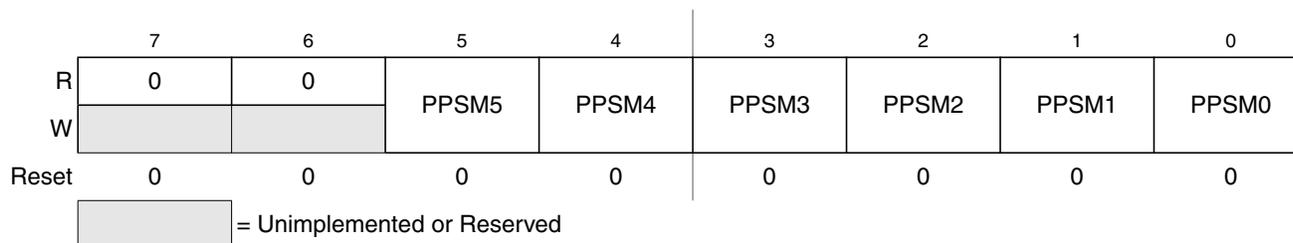


Figure 2-22. Port M Polarity Select Register (PPSM)

Read: Anytime.

Write: Anytime.

Table 2-20. PPSM Field Descriptions

Field	Description
5–0 PPSM[5:0]	<p>Polarity Select Port M — This register selects whether a pull-down or a pull-up device is connected to the pin.</p> <p>0 A pull-up device is connected to the associated port M pin, if enabled by the associated bit in register PERM and if the port is used as input or as wired-or output.</p> <p>1 A pull-down device is connected to the associated port M pin, if enabled by the associated bit in register PERM and if the port is used as input.</p>

2.3.2.3.7 Port M Wired-OR Mode Register (WOMM)

Module Base + 0x0016

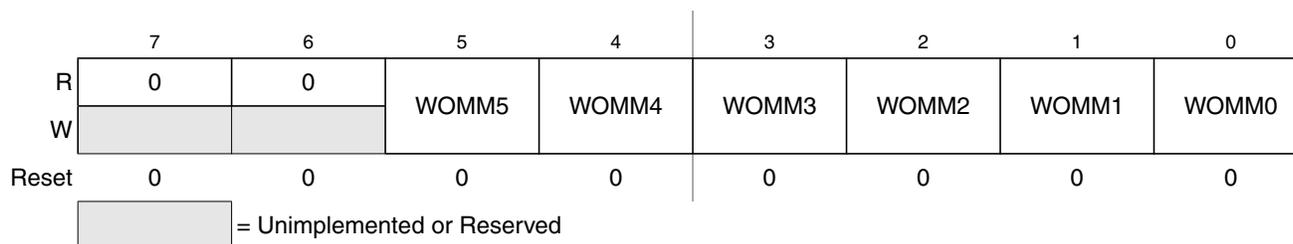


Figure 2-23. Port M Wired-OR Mode Register (WOMM)

Read: Anytime.

Write: Anytime.

Table 2-21. WOMM Field Descriptions

Field	Description
5–0 WOMM[5:0]	<p>Wired-OR Mode Port M — This register configures the output pins as wired-or. If enabled the output is driven active low only (open-drain). A logic level of “1” is not driven. This bit has no influence on pins used as inputs.</p> <p>0 Output buffers operate as push-pull outputs.</p> <p>1 Output buffers operate as open-drain outputs.</p>

Table 3-14. Program Page Index Register Bits

PIX5	PIX4	PIX3	PIX2	PIX1	PIX0	Program Space Selected
0	0	0	0	0	0	16K page 0
0	0	0	0	0	1	16K page 1
0	0	0	0	1	0	16K page 2
0	0	0	0	1	1	16K page 3
.
.
.
.
.
1	1	1	1	0	0	16K page 60
1	1	1	1	0	1	16K page 61
1	1	1	1	1	0	16K page 62
1	1	1	1	1	1	16K page 63

3.4 Functional Description

The MMC sub-block performs four basic functions of the core operation: bus control, address decoding and select signal generation, memory expansion, and security decoding for the system. Each aspect is described in the following subsections.

3.4.1 Bus Control

The MMC controls the address bus and data buses that interface the core with the rest of the system. This includes the multiplexing of the input data buses to the core onto the main CPU read data bus and control of data flow from the CPU to the output address and data buses of the core. In addition, the MMC manages all CPU read data bus swapping operations.

3.4.2 Address Decoding

As data flows on the core address bus, the MMC decodes the address information, determines whether the internal core register or firmware space, the peripheral space or a memory register or array space is being addressed and generates the correct select signal. This decoding operation also interprets the mode of operation of the system and the state of the mapping control registers in order to generate the proper select. The MMC also generates two external chip select signals, emulation chip select (\overline{ECS}) and external chip select (\overline{XCS}).

3.4.2.1 Select Priority and Mode Considerations

Although internal resources such as control registers and on-chip memory have default addresses, each can be relocated by changing the default values in control registers. Normally, I/O addresses, control registers,

- Nine hardware commands using free cycles, if available, for minimal CPU intervention
- Hardware commands not requiring active BDM
- 15 firmware commands execute from the standard BDM firmware lookup table
- Instruction tagging capability
- Software control of BDM operation during wait mode
- Software selectable clocks
- When secured, hardware commands are allowed to access the register space in special single-chip mode, if the FLASH and EEPROM erase tests fail.

6.1.2 Modes of Operation

BDM is available in all operating modes but must be enabled before firmware commands are executed. Some system peripherals may have a control bit which allows suspending the peripheral function during background debug mode.

6.1.2.1 Regular Run Modes

All of these operations refer to the part in run mode. The BDM does not provide controls to conserve power during run mode.

- Normal operation
General operation of the BDM is available and operates the same in all normal modes.
- Special single-chip mode
In special single-chip mode, background operation is enabled and active out of reset. This allows programming a system with blank memory.
- Special peripheral mode
BDM is enabled and active immediately out of reset. BDM can be disabled by clearing the BDMACT bit in the BDM status (BDMSTS) register. The BDM serial system should not be used in special peripheral mode.

NOTE

The BDM serial system should not be used in special peripheral mode since the CPU, which in other modes interfaces with the BDM to relinquish control of the bus during a free cycle or a steal operation, is not operating in this mode.

- Emulation modes
General operation of the BDM is available and operates the same as in normal modes.

6.1.2.2 Secure Mode Operation

If the part is in secure mode, the operation of the BDM is reduced to a small subset of its regular run mode operation. Secure operation prevents access to FLASH or EEPROM other than allowing erasure.

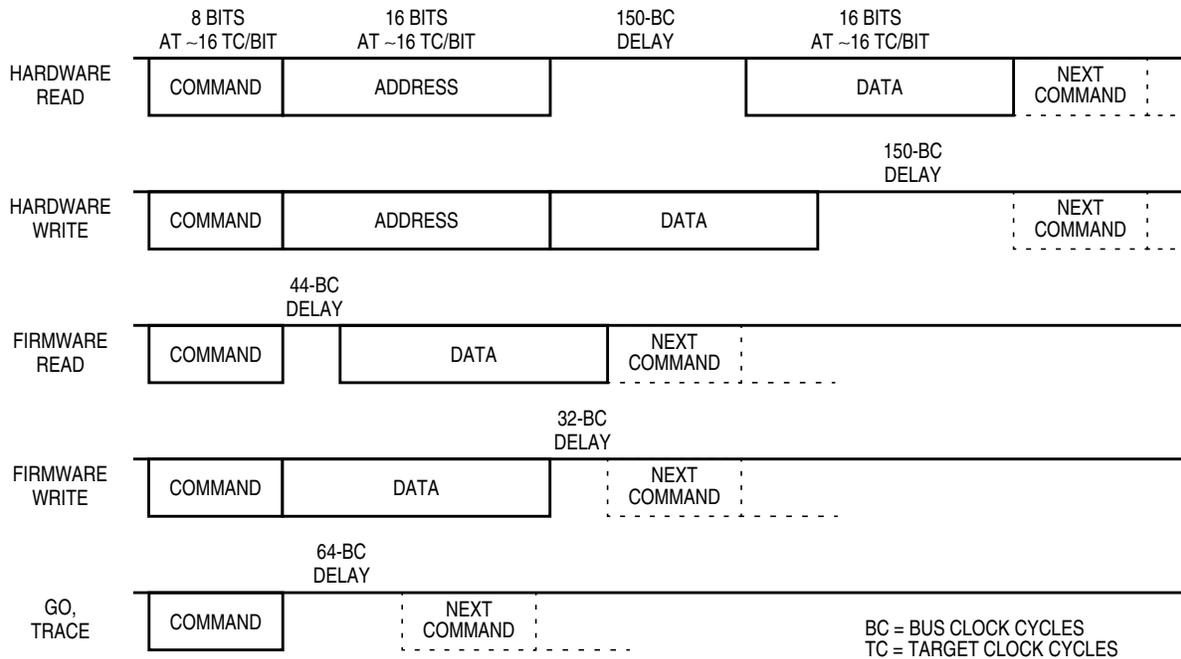


Figure 6-6. BDM Command Structure

6.4.6 BDM Serial Interface

The BDM communicates with external devices serially via the BKGD pin. During reset, this pin is a mode select input which selects between normal and special modes of operation. After reset, this pin becomes the dedicated serial interface pin for the BDM.

The BDM serial interface is timed using the clock selected by the CLKS_W bit in the status register see [Section 6.3.2.1, “BDM Status Register \(BDMSTS\).”](#) This clock will be referred to as the target clock in the following explanation.

The BDM serial interface uses a clocking scheme in which the external host generates a falling edge on the BKGD pin to indicate the start of each bit time. This falling edge is sent for every bit whether data is transmitted or received. Data is transferred most significant bit (MSB) first at 16 target clock cycles per bit. The interface times out if 512 clock cycles occur between falling edges from the host.

The BKGD pin is a pseudo open-drain pin and has an weak on-chip active pull-up that is enabled at all times. It is assumed that there is an external pull-up and that drivers connected to BKGD do not typically drive the high level. Because R-C rise time could be unacceptably long, the target system and host provide brief driven-high (speedup) pulses to drive BKGD to a logic 1. The source of this speedup pulse is the host for transmit cases and the target for receive cases.

The timing for host-to-target is shown in [Figure 6-7](#) and that of target-to-host in [Figure 6-8](#) and [Figure 6-9](#). All four cases begin when the host drives the BKGD pin low to generate a falling edge. Because the host and target are operating from separate clocks, it can take the target system up to one full clock cycle to recognize this edge. The target measures delays from this perceived start of the bit time while the host measures delays from the point it actually drove BKGD low to start the bit up to one target clock cycle

The commands are described as follows:

- **ACK_ENABLE** — enables the hardware handshake protocol. The target will issue the ACK pulse when a CPU command is executed by the CPU. The **ACK_ENABLE** command itself also has the ACK pulse as a response.
- **ACK_DISABLE** — disables the ACK pulse protocol. In this case, the host needs to use the worst case delay time at the appropriate places in the protocol.

The default state of the BDM after reset is hardware handshake protocol disabled.

All the read commands will ACK (if enabled) when the data bus cycle has completed and the data is then ready for reading out by the BKGD serial pin. All the write commands will ACK (if enabled) after the data has been received by the BDM through the BKGD serial pin and when the data bus cycle is complete. See [Section 6.4.3, “BDM Hardware Commands,”](#) and [Section 6.4.4, “Standard BDM Firmware Commands,”](#) for more information on the BDM commands.

The **ACK_ENABLE** sends an ACK pulse when the command has been completed. This feature could be used by the host to evaluate if the target supports the hardware handshake protocol. If an ACK pulse is issued in response to this command, the host knows that the target supports the hardware handshake protocol. If the target does not support the hardware handshake protocol the ACK pulse is not issued. In this case, the **ACK_ENABLE** command is ignored by the target because it is not recognized as a valid command.

The **BACKGROUND** command will issue an ACK pulse when the CPU changes from normal to background mode. The ACK pulse related to this command could be aborted using the **SYNC** command.

The **GO** command will issue an ACK pulse when the CPU exits from background mode. The ACK pulse related to this command could be aborted using the **SYNC** command.

The **GO_UNTIL** command is equivalent to a **GO** command with exception that the ACK pulse, in this case, is issued when the CPU enters into background mode. This command is an alternative to the **GO** command and should be used when the host wants to trace if a breakpoint match occurs and causes the CPU to enter active background mode. Note that the ACK is issued whenever the CPU enters BDM, which could be caused by a breakpoint match or by a **BGND** instruction being executed. The ACK pulse related to this command could be aborted using the **SYNC** command.

The **TRACE1** command has the related ACK pulse issued when the CPU enters background active mode after one instruction of the application program is executed. The ACK pulse related to this command could be aborted using the **SYNC** command.

The **TAGGO** command will not issue an ACK pulse because this would interfere with the tagging function shared on the same pin.

Table 7-12. DBGCC Field Descriptions

Field	Description
15:0	Comparator C Compare Bits — The comparator C compare bits control whether comparator C will compare the address bus bits [15:0] to a logic 1 or logic 0. See Table 7-13 . 0 Compare corresponding address bit to a logic 0 1 Compare corresponding address bit to a logic 1 Note: This register will be cleared automatically when the DBG module is armed in LOOP1 mode.

Table 7-13. Comparator C Compares

PAGSEL	EXTCMP Compare	High-Byte Compare
x0	No compare	DBGCCCH[7:0] = AB[15:8]
x1	EXTCMP[5:0] = XAB[21:16]	DBGCCCH[7:0] = XAB[15:14],AB[13:8]

7.3.2.7 Debug Control Register 2 (DBGC2)

Module Base + 0x0028

Starting address location affected by INITRG register setting.

	7	6	5	4	3	2	1	0
R	BKABEN ⁽¹⁾	FULL	BDM	TAGAB	BKCEN ⁽²⁾	TAGC ²	RWCEN ²	RWC ²
W								
Reset	0	0	0	0	0	0	0	0

- When BKABEN is set (BKP mode), all bits in DBGC2 are available. When BKABEN is cleared and DBG is used in DBG mode, bits FULL and TAGAB have no meaning.
- These bits can be used in BKP mode and DBG mode (when capture mode is not set in LOOP1) to provide a third breakpoint.

Figure 7-13. Debug Control Register 2 (DBGC2)
Table 7-14. DBGC2 Field Descriptions

Field	Description
7 BKABEN	Breakpoint Using Comparator A and B Enable — This bit enables the breakpoint capability using comparator A and B, when set (BKP mode) the DBGEN bit in DBGC1 cannot be set. 0 Breakpoint module off 1 Breakpoint module on
6 FULL	Full Breakpoint Mode Enable — This bit controls whether the breakpoint module is in dual mode or full mode. In full mode, comparator A is used to match address and comparator B is used to match data. See Section 7.4.1.2, “Full Breakpoint Mode,” for more details. 0 Dual address mode enabled 1 Full breakpoint mode enabled
5 BDM	Background Debug Mode Enable — This bit determines if the breakpoint causes the system to enter background debug mode (BDM) or initiate a software interrupt (SWI). 0 Go to software interrupt on a break request 1 Go to BDM on a break request

Address	Name		Bit 7	6	5	4	3	2	1	Bit 0
0x001E	ATDDR7H	R	BIT 9 MSB BIT 7 MSB	BIT 8 BIT 6	BIT 7 BIT 5	BIT 6 BIT 4	BIT 5 BIT 3	BIT 4 BIT 2	BIT 3 BIT 1	BIT 2 BIT 0
		W								
0x001F	ATDDR7L	R	BIT 1 u	BIT 0 u	0 0	0 0	0 0	0 0	0 0	0 0
		W								
Right Justified Result Data										
0x0010	ATDDR0H	R	0 0	0 0	0 0	0 0	0 0	0 0	BIT 9 MSB 0	BIT 8 0
		W								
0x0011	ATDDR0L	R	BIT 7 BIT 7 MSB	BIT 6 BIT 6	BIT 5 BIT 5	BIT 4 BIT 4	BIT 3 BIT 3	BIT 2 BIT 2	BIT 1 BIT 1	BIT 0 BIT 0
		W								
0x0012	ATDDR1H	R	0 0	0 0	0 0	0 0	0 0	0 0	BIT 9 MSB 0	BIT 8 0
		W								
0x0013	ATDDR1L	R	BIT 7 BIT 7 MSB	BIT 6 BIT 6	BIT 5 BIT 5	BIT 4 BIT 4	BIT 3 BIT 3	BIT 2 BIT 2	BIT 1 BIT 1	BIT 0 BIT 0
		W								
0x0014	ATDDR2H	R	0 0	0 0	0 0	0 0	0 0	0 0	BIT 9 MSB 0	BIT 8 0
		W								
0x0015	ATDDR2L	R	BIT 7 BIT 7 MSB	BIT 6 BIT 6	BIT 5 BIT 5	BIT 4 BIT 4	BIT 3 BIT 3	BIT 2 BIT 2	BIT 1 BIT 1	BIT 0 BIT 0
		W								
0x0016	ATDDR3H	R	0 0	0 0	0 0	0 0	0 0	0 0	BIT 9 MSB 0	BIT 8 0
		W								
0x0017	ATDDR3L	R	BIT 7 BIT 7 MSB	BIT 6 BIT 6	BIT 5 BIT 5	BIT 4 BIT 4	BIT 3 BIT 3	BIT 2 BIT 2	BIT 1 BIT 1	BIT 0 BIT 0
		W								
0x0018	ATDDR4H	R	0 0	0 0	0 0	0 0	0 0	0 0	BIT 9 MSB 0	BIT 8 0
		W								
0x0019	ATDDR4L	R	BIT 7 BIT 7 MSB	BIT 6 BIT 6	BIT 5 BIT 5	BIT 4 BIT 4	BIT 3 BIT 3	BIT 2 BIT 2	BIT 1 BIT 1	BIT 0 BIT 0
		W								
0x001A	ATDDR5H	R	0 0	0 0	0 0	0 0	0 0	0 0	BIT 9 MSB 0	BIT 8 0
		W								
0x001B	ATDDR5L	R	BIT 7 BIT 7 MSB	BIT 6 BIT 6	BIT 5 BIT 5	BIT 4 BIT 4	BIT 3 BIT 3	BIT 2 BIT 2	BIT 1 BIT 1	BIT 0 BIT 0
		W								

= Unimplemented or Reserved

Figure 8-2. ATD Register Summary (Sheet 3 of 4)

Address	Name		Bit 7	6	5	4	3	2	1	Bit 0
0x001C	ATDDR6H	R	0	0	0	0	0	0	BIT 9 MSB	BIT 8
		W	0	0	0	0	0	0	0	0
0x001D	ATDDR6L	R	BIT 7 BIT 7 MSB	BIT 6 BIT 6	BIT 5 BIT 5	BIT 4 BIT 4	BIT 3 BIT 3	BIT 2 BIT 2	BIT 1 BIT 1	BIT 0 BIT 0
		W								
0x001E	ATDDR7H	R	0	0	0	0	0	0	BIT 9 MSB	BIT 8
		W	0	0	0	0	0	0	0	0
0x001F	ATDDR7L	R	BIT 7 BIT 7 MSB	BIT 6 BIT 6	BIT 5 BIT 5	BIT 4 BIT 4	BIT 3 BIT 3	BIT 2 BIT 2	BIT 1 BIT 1	BIT 0 BIT 0
		W								

 = Unimplemented or Reserved

Figure 8-2. ATD Register Summary (Sheet 4 of 4)

NOTE

Register Address = Module Base Address + Address Offset, where the Module Base Address is defined at the MCU level and the Address Offset is defined at the module level.

In cases of more than one buffer having the same lowest priority, the message buffer with the lower index number wins.

Module Base + 0xXXXX

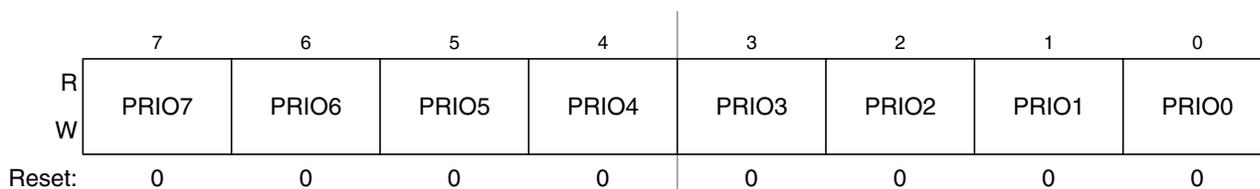


Figure 10-35. Transmit Buffer Priority Register (TBPR)

Read: Anytime when TXEx flag is set (see Section 10.3.2.7, “MSCAN Transmitter Flag Register (CANTFLG)”) and the corresponding transmit buffer is selected in CANTBSEL (see Section 10.3.2.11, “MSCAN Transmit Buffer Selection Register (CANTBSEL)”).

Write: Anytime when TXEx flag is set (see Section 10.3.2.7, “MSCAN Transmitter Flag Register (CANTFLG)”) and the corresponding transmit buffer is selected in CANTBSEL (see Section 10.3.2.11, “MSCAN Transmit Buffer Selection Register (CANTBSEL)”).

10.3.3.5 Time Stamp Register (TSRH–TSRL)

If the TIME bit is enabled, the MSCAN will write a time stamp to the respective registers in the active transmit or receive buffer right after the EOF of a valid message on the CAN bus (see Section 10.3.2.1, “MSCAN Control Register 0 (CANCTL0)”). In case of a transmission, the CPU can only read the time stamp after the respective transmit buffer has been flagged empty.

The timer value, which is used for stamping, is taken from a free running internal CAN bit clock. A timer overrun is not indicated by the MSCAN. The timer is reset (all bits set to 0) during initialization mode. The CPU can only read the time stamp registers.

Module Base + 0xXXXE

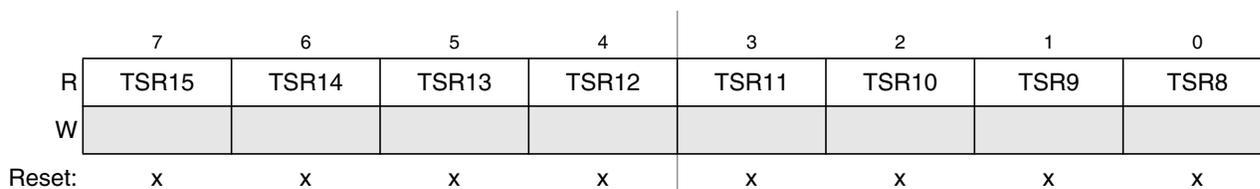


Figure 10-36. Time Stamp Register — High Byte (TSRH)

Module Base + 0xXXXF

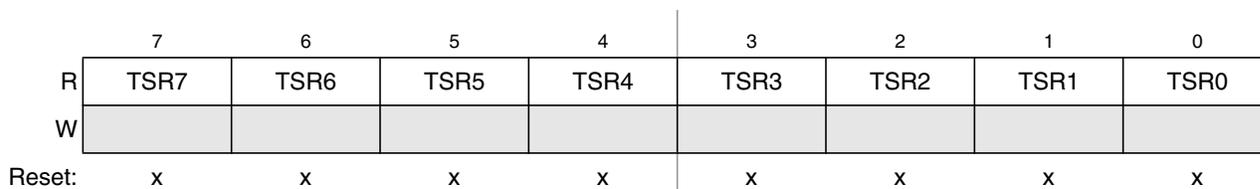


Figure 10-37. Time Stamp Register — Low Byte (TSRL)

Table 12-4. PWMCLK Field Descriptions

Field	Description
5 PCLK5	Pulse Width Channel 5 Clock Select 0 Clock A is the clock source for PWM channel 5. 1 Clock SA is the clock source for PWM channel 5.
4 PCLK4	Pulse Width Channel 4 Clock Select 0 Clock A is the clock source for PWM channel 4. 1 Clock SA is the clock source for PWM channel 4.
3 PCLK3	Pulse Width Channel 3 Clock Select 0 Clock B is the clock source for PWM channel 3. 1 Clock SB is the clock source for PWM channel 3.
2 PCLK2	Pulse Width Channel 2 Clock Select 0 Clock B is the clock source for PWM channel 2. 1 Clock SB is the clock source for PWM channel 2.
1 PCLK1	Pulse Width Channel 1 Clock Select 0 Clock A is the clock source for PWM channel 1. 1 Clock SA is the clock source for PWM channel 1.
0 PCLK0	Pulse Width Channel 0 Clock Select 0 Clock A is the clock source for PWM channel 0. 1 Clock SA is the clock source for PWM channel 0.

12.3.2.4 PWM Prescale Clock Select Register (PWMPRCLK)

This register selects the prescale clock source for clocks A and B independently.

Module Base + 0x0003

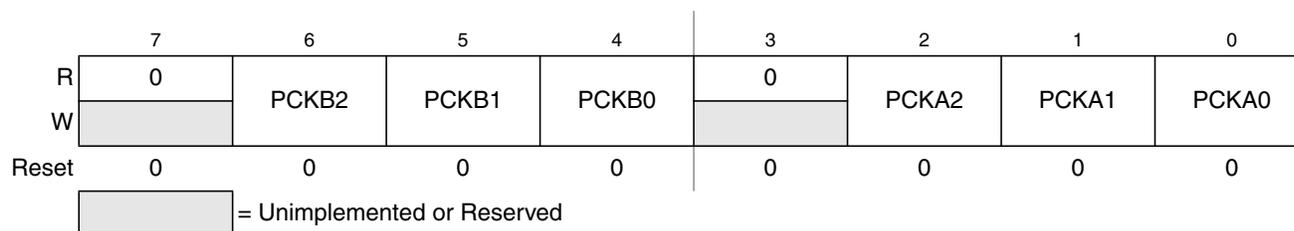


Figure 12-6. PWM Prescaler Clock Select Register (PWMPRCLK)

Read: anytime

Write: anytime

NOTE

PCKB2–PCKB0 and PCKA2–PCKA0 register bits can be written anytime. If the clock prescale is changed while a PWM signal is being generated, a truncated or stretched pulse can occur during the transition.

To calculate the output frequency in center aligned output mode for a particular channel, take the selected clock source frequency for the channel (A, B, SA, or SB) and divide it by twice the value in the period register for that channel.

- $PWMx \text{ frequency} = \text{clock (A, B, SA, or SB)} / (2 * PWMPERx)$
- PWMx duty cycle (high time as a% of period):
 - Polarity = 0 (PPOLx = 0)
 $Duty \text{ cycle} = [(PWMPERx - PWMDTYx) / PWMPERx] * 100\%$
 - Polarity = 1 (PPOLx = 1)
 $Duty \text{ cycle} = [PWMDTYx / PWMPERx] * 100\%$

As an example of a center aligned output, consider the following case:

Clock source = bus clock, where bus clock = 10 MHz (100 ns period)
 PPOLx = 0
 PWMPERx = 4
 PWMDTYx = 1
 PWMx frequency = $10 \text{ MHz} / 8 = 1.25 \text{ MHz}$
 PWMx period = 800 ns
 PWMx duty cycle = $3/4 * 100\% = 75\%$

Shown below is the output waveform generated.

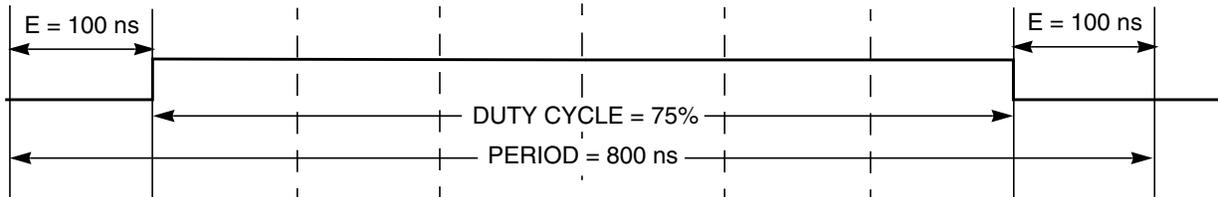


Figure 12-39. PWM Center Aligned Output Example Waveform

12.4.2.7 PWM 16-Bit Functions

The PWM timer also has the option of generating 6-channels of 8-bits or 3-channels of 16-bits for greater PWM resolution}. This 16-bit channel option is achieved through the concatenation of two 8-bit channels.

The PWMCTL register contains three control bits, each of which is used to concatenate a pair of PWM channels into one 16-bit channel. Channels 4 and 5 are concatenated with the CON45 bit, channels 2 and 3 are concatenated with the CON23 bit, and channels 0 and 1 are concatenated with the CON01 bit.

NOTE

Change these bits only when both corresponding channels are disabled.

When channels 4 and 5 are concatenated, channel 4 registers become the high-order bytes of the double byte channel as shown in Figure 12-40. Similarly, when channels 2 and 3 are concatenated, channel 2 registers become the high-order bytes of the double byte channel. When channels 0 and 1 are concatenated, channel 0 registers become the high-order bytes of the double byte channel.

13.4 Functional Description

This section provides a complete functional description of the SCI block, detailing the operation of the design from the end user perspective in a number of subsections.

Figure 13-9 shows the structure of the SCI module. The SCI allows full duplex, asynchronous, NRZ serial communication between the CPU and remote devices, including other CPUs. The SCI transmitter and receiver operate independently, although they use the same baud rate generator. The CPU monitors the status of the SCI, writes the data to be transmitted, and processes received data.

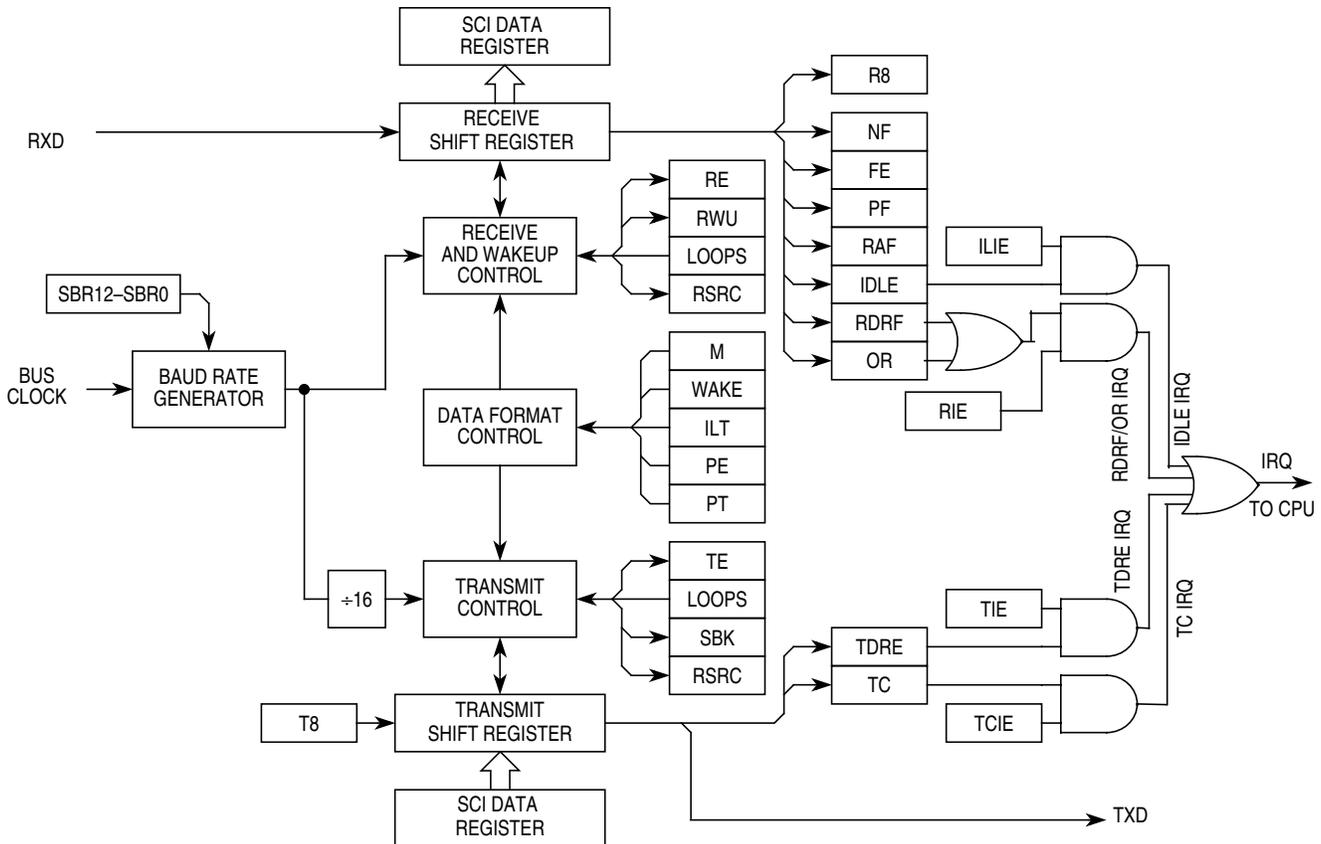


Figure 13-9. SCI Block Diagram

13.4.5 Single-Wire Operation

Normally, the SCI uses two pins for transmitting and receiving. In single-wire operation, the RXD pin is disconnected from the SCI. The SCI uses the TXD pin for both receiving and transmitting.

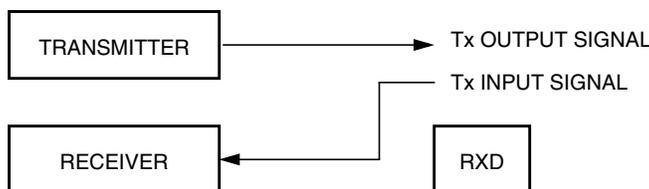


Figure 13-22. Single-Wire Operation (LOOPS = 1, RSRC = 1)

Enable single-wire operation by setting the LOOPS bit and the receiver source bit, RSRC, in SCI control register 1 (SCICR1). Setting the LOOPS bit disables the path from the **Rx Input** signal to the receiver. Setting the RSRC bit connects the receiver input to the output of the TXD pin driver. Both the transmitter and receiver must be enabled (TE = 1 and RE = 1). The TXDIR bit (SCISR2[1]) determines whether the TXD pin is going to be used as an input (TXDIR = 0) or an output (TXDIR = 1) in this mode of operation.

13.4.6 Loop Operation

In loop operation the transmitter output goes to the receiver input. The **Rx Input** signal is disconnected from the SCI

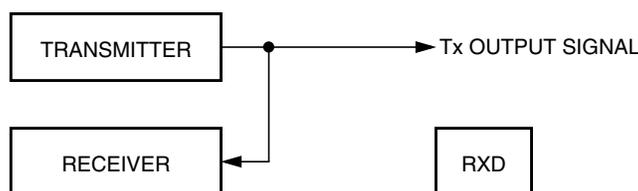


Figure 13-23. Loop Operation (LOOPS = 1, RSRC = 0)

Enable loop operation by setting the LOOPS bit and clearing the RSRC bit in SCI control register 1 (SCICR1). Setting the LOOPS bit disables the path from the **Rx Input** signal to the receiver. Clearing the RSRC bit connects the transmitter output to the receiver input. Both the transmitter and receiver must be enabled (TE = 1 and RE = 1).

13.5 Initialization Information

13.5.1 Reset Initialization

The reset state of each individual bit is listed in [Section 13.3, “Memory Map and Registers”](#) which details the registers and their bit fields. All special functions or modes which are initialized during or just following reset are described within this section.

15.3.2 Register Descriptions

This section consists of register descriptions in address order. Each description includes a standard register diagram with an associated figure number. Details of register bit and field function follow the register diagrams, in bit order.

Register Name		Bit 7	6	5	4	3	2	1	Bit 0
0x0000 TIOS	R W	IOS7	IOS6	IOS5	IOS4	IOS3	IOS2	IOS1	IOS0
0x0001 CFORC	R W	0 FOC7	0 FOC6	0 FOC5	0 FOC4	0 FOC3	0 FOC2	0 FOC1	0 FOC0
0x0002 OC7M	R W	OC7M7	OC7M6	OC7M5	OC7M4	OC7M3	OC7M2	OC7M1	OC7M0
0x0003 OC7D	R W	OC7D7	OC7D6	OC7D5	OC7D4	OC7D3	OC7D2	OC7D1	OC7D0
0x0004 TCNTH	R W	TCNT15	TCNT14	TCNT13	TCNT12	TCNT11	TCNT10	TCNT9	TCNT8
0x0005 TCNTL	R W	TCNT7	TCNT6	TCNT5	TCNT4	TCNT3	TCNT2	TCNT1	TCNT0
0x0006 TSCR1	R W	TEN	TSWAI	TSFRZ	TFFCA	0	0	0	0
0x0007 TTOV	R W	TOV7	TOV6	TOV5	TOV4	TOV3	TOV2	TOV1	TOV0
0x0008 TCTL1	R W	OM7	OL7	OM6	OL6	OM5	OL5	OM4	OL4
0x0009 TCTL2	R W	OM3	OL3	OM2	OL2	OM1	OL1	OM0	OL0
0x000A TCTL3	R W	EDG7B	EDG7A	EDG6B	EDG6A	EDG5B	EDG5A	EDG4B	EDG4A
0x000B TCTL4	R W	EDG3B	EDG3A	EDG2B	EDG2A	EDG1B	EDG1A	EDG0B	EDG0A
0x000C TIE	R W	C7I	C6I	C5I	C4I	C3I	C2I	C1I	C0I

= Unimplemented or Reserved

Figure 15-5. TIM16B8CV1 Register Summary

16.2 External Signal Description

Due to the nature of VREG3V3V2 being a voltage regulator providing the chip internal power supply voltages most signals are power supply signals connected to pads.

Table 16-1 shows all signals of VREG3V3V2 associated with pins.

Table 16-1. VREG3V3V2 — Signal Properties

Name	Port	Function	Reset State	Pull Up
V_{DDR}	—	VREG3V3V2 power input (positive supply)	—	—
V_{DDA}	—	VREG3V3V2 quiet input (positive supply)	—	—
V_{SSA}	—	VREG3V3V2 quiet input (ground)	—	—
V_{DD}	—	VREG3V3V2 primary output (positive supply)	—	—
V_{SS}	—	VREG3V3V2 primary output (ground)	—	—
V_{DDPLL}	—	VREG3V3V2 secondary output (positive supply)	—	—
V_{SSPLL}	—	VREG3V3V2 secondary output (ground)	—	—
V_{REGEN} (optional)	—	VREG3V3V2 (Optional) Regulator Enable	—	—

NOTE

Check device overview chapter for connectivity of the signals.

16.2.1 V_{DDR} — Regulator Power Input

Signal V_{DDR} is the power input of VREG3V3V2. All currents sourced into the regulator loads flow through this pin. A chip external decoupling capacitor (100 nF...220 nF, X7R ceramic) between V_{DDR} and V_{SSR} can smoothen ripple on V_{DDR} .

For entering Shutdown Mode, pin V_{DDR} should also be tied to ground on devices without a V_{REGEN} pin.

16.2.2 V_{DDA} , V_{SSA} — Regulator Reference Supply

Signals V_{DDA}/V_{SSA} which are supposed to be relatively quiet are used to supply the analog parts of the regulator. Internal precision reference circuits are supplied from these signals. A chip external decoupling capacitor (100 nF...220 nF, X7R ceramic) between V_{DDA} and V_{SSA} can further improve the quality of this supply.

19.3.2 Register Descriptions

The Flash module contains a set of 16 control and status registers located between module base + 0x0000 and 0x000F. A summary of the Flash module registers is given in Figure 19-5. Detailed descriptions of each register bit are provided.

Register Name		Bit 7	6	5	4	3	2	1	Bit 0
0x0000	R	FDIVLD	PRDIV8	FDIV5	FDIV4	FDIV3	FDIV2	FDIV1	FDIV0
FCLKDIV	W								
0x0001	R	KEYEN1	KEYEN0	NV5	NV4	NV3	NV2	SEC1	SEC0
FSEC	W								
0x0002	R	0	0	0	0	0	0	0	0
RESERVED1 ⁽¹⁾	W								
0x0003	R	CBEIE	CCIE	KEYACC	0	0	0	0	0
FCNFG	W								
0x0004	R	FPOPEN	NV6	FPHDIS	FPHS1	FPHS0	FPLDIS	FPLS1	FPLS0
FPROT	W								
0x0005	R	CBEIF	CCIF	PVIOL	ACCERR	0	BLANK	FAIL	DONE
FSTAT	W								
0x0006	R	0	CMDB6	CMDB5	0	0	CMDB2	0	CMDB0
FCMD	W								
0x0007	R	0	0	0	0	0	0	0	0
RESERVED2 ¹	W								
0x0008	R	FABHI							
FADDRHI ¹	W								
0x0008	R	0	FABHI						
FADDRHI ¹	W								
0x0009	R	FABLO							
FADDRLO ¹	W								
0x000A	R	FDHI							
FDATAHI ¹	W								
0x000B	R	FDLO							
FDATALO ¹	W								
0x000C	R	0	0	0	0	0	0	0	0
RESERVED3 ¹	W								
0x000D	R	0	0	0	0	0	0	0	0
RESERVED4 ¹	W								
0x000E	R	0	0	0	0	0	0	0	0
RESERVED5 ¹	W								
0x000F	R	0	0	0	0	0	0	0	0
RESERVED6 ¹	W								

= Unimplemented or Reserved

Figure 19-5. Flash Register Summary

1. Intended for factory test purposes only.

then FCLKDIV register bits PRDIV8 and FDIV[5:0] are to be set as described in Figure 21-21.

For example, if the oscillator clock frequency is 950 kHz and the bus clock is 10 MHz, FCLKDIV bits FDIV[5:0] should be set to 4 (000100) and bit PRDIV8 set to 0. The resulting FCLK is then 190 kHz. As a result, the Flash algorithm timings are increased over optimum target by:

$$(200 - 190) / 200 \times 100 = 5\%$$

Command execution time will increase proportionally with the period of FCLK.

CAUTION

Because of the impact of clock synchronization on the accuracy of the functional timings, programming or erasing the Flash array cannot be performed if the bus clock runs at less than 1 MHz. Programming or erasing the Flash array with an input clock < 150 kHz should be avoided. Setting FCLKDIV to a value such that $FCLK < 150$ kHz can destroy the Flash array due to overstress. Setting FCLKDIV to a value such that $(1/FCLK + T_{bus}) < 5\mu s$ can result in incomplete programming or erasure of the Flash array cells.

If the FCLKDIV register is written, the bit FDIVLD is set automatically. If the FDIVLD bit is 0, the FCLKDIV register has not been written since the last reset. If the FCLKDIV register has not been written to, the Flash command loaded during a command write sequence will not execute and the ACCERR flag in the FSTAT register will set.

Appendix A

Electrical Characteristics

A.1 General

NOTE

The electrical characteristics given in this section are preliminary and should be used as a guide only. Values cannot be guaranteed by Freescale and are subject to change without notice.

The parts are specified and tested over the 5V and 3.3V ranges. For the intermediate range, generally the electrical specifications for the 3.3V range apply, but the parts are not tested in production test in the intermediate range.

This supplement contains the most accurate electrical information for the MC9S12C-Family / MC9S12GC-Family microcontrollers available at the time of publication. The information should be considered **PRELIMINARY** and is subject to change.

This introduction is intended to give an overview on several common topics like power supply, current injection etc.

A.1.1 Parameter Classification

The electrical parameters shown in this supplement are guaranteed by various methods. To give the customer a better understanding the following classification is used and the parameters are tagged accordingly in the tables where appropriate.

NOTE

This classification will be added at a later release of the specification

- P: Those parameters are guaranteed during production testing on each individual device.
- C: Those parameters are achieved by the design characterization by measuring a statistically relevant sample size across process variations. They are regularly verified by production monitors.
- T: Those parameters are achieved by design characterization on a small sample size from typical devices. All values shown in the typical column are within this category.
- D: Those parameters are derived mainly from simulations.

A.1.2 Power Supply

The MC9S12C-Family / MC9S12GC-Family and MC9S12GC Family members utilize several pins to supply power to the I/O ports, A/D converter, oscillator and PLL as well as the internal logic.

The V_{DDA} , V_{SSA} pair supplies the A/D converter.

The V_{DDX} , V_{SSX} pair supplies the I/O pins

The V_{DDR} , V_{SSR} pair supplies the internal voltage regulator.

Table A-7. 3.3V I/O Characteristics

Conditions are $V_{DDX}=3.3V \pm 10\%$, Temperature from $-40^{\circ}C$ to $+140^{\circ}C$, unless otherwise noted							
Num	C	Rating	Symbol	Min	Typ	Max	Unit
1	P	Input High Voltage	V_{IH}	$0.65 \cdot V_{DD5}$	—	—	V
	T	Input High Voltage	V_{IH}	—	—	$V_{DD5} + 0.3$	V
2	P	Input Low Voltage	V_{IL}	—	—	$0.35 \cdot V_{DD5}$	V
	T	Input Low Voltage	V_{IL}	$V_{SS5} - 0.3$	—	—	V
3	C	Input Hysteresis	V_{HYS}	—	250	—	mV
4	P	Input Leakage Current (pins in high ohmic input mode) ⁽¹⁾ $V_{in} = V_{DD5}$ or V_{SS5}	I_{in}	-1	—	1	μA
5	C	Output High Voltage (pins in output mode) Partial Drive $I_{OH} = -0.75mA$	V_{OH}	$V_{DD5} - 0.4$	—	—	V
6	P	Output High Voltage (pins in output mode) Full Drive $I_{OH} = -4mA$	V_{OH}	$V_{DD5} - 0.4$	—	—	V
7	C	Output Low Voltage (pins in output mode) Partial Drive $I_{OL} = +0.9mA$	V_{OL}	—	—	0.4	V
8	P	Output Low Voltage (pins in output mode) Full Drive $I_{OL} = +4.75mA$	V_{OL}	—	—	0.4	V
9	P	Internal Pull Up Device Current, tested at V_{IL} Max.	I_{PUL}	—	—	-60	μA
10	C	Internal Pull Up Device Current, tested at V_{IH} Min.	I_{PUH}	-6	—	—	μA
11	P	Internal Pull Down Device Current, tested at V_{IH} Min.	I_{PDH}	—	—	60	μA
12	C	Internal Pull Down Device Current, tested at V_{IL} Max.	I_{PDL}	6	—	—	μA
11	D	Input Capacitance	C_{in}	—	7	—	$\pi\Phi$
12	T	Injection current ⁽²⁾ Single Pin limit Total Device Limit. Sum of all injected currents	I_{ICS} I_{ICP}	-2.5 -25	—	2.5 25	μA
13	P	Port P, J Interrupt Input Pulse filtered ⁽³⁾	t_{PIGN}	—	—	3	μs
14	P	Port P, J Interrupt Input Pulse passed ³	t_{PVAL}	10	—	—	μs

1. Maximum leakage current occurs at maximum operating temperature. Current decreases by approximately one-half for each 8 C to 12 C in the temperature range from 50 C to 125 C

2. Refer to Section A.1.4, “Current Injection”, for more details

3. Parameter only applies in STOP or Pseudo STOP mode.

A.1.10 Supply Currents

This section describes the current consumption characteristics of the device as well as the conditions for the measurements.

A.1.10.1 Measurement Conditions

All measurements are without output loads. Unless otherwise noted the currents are measured in single chip mode, internal voltage regulator enabled and at 25MHz bus frequency using a 4MHz oscillator.

A.4.1.3 SRAM Data Retention

Provided an appropriate external reset signal is applied to the MCU, preventing the CPU from executing code when V_{DD5} is out of specification limits, the SRAM contents integrity is guaranteed if after the reset the PORF bit in the CRG Flags Register has not been set.

A.4.1.4 External Reset

When external reset is asserted for a time greater than PW_{RSTL} the CRG module generates an internal reset, and the CPU starts fetching the reset vector without doing a clock quality check, if there was an oscillation before reset.

A.4.1.5 Stop Recovery

Out of STOP the controller can be woken up by an external interrupt. A clock quality check as after POR is performed before releasing the clocks to the system.

A.4.1.6 Pseudo Stop and Wait Recovery

The recovery from Pseudo STOP and Wait are essentially the same since the oscillator was not stopped in both modes. In Pseudo Stop Mode the voltage regulator is switched to reduced performance mode to reduce power consumption. The returning out of pseudo stop to full performance takes t_{vup} . The controller can be woken up by internal or external interrupts. After t_{wrs} in Wait or $t_{vup} + t_{wrs}$ in Pseudo Stop the CPU starts fetching the interrupt vector.

A.4.2 Oscillator

The device features an internal Colpitts and Pierce oscillator. The selection of Colpitts oscillator or Pierce oscillator/external clock depends on the XCLKS signal which is sampled during reset. Pierce oscillator/external clock mode allows the input of a square wave. Before asserting the oscillator to the internal system clocks the quality of the oscillation is checked for each start from either power-on, STOP or oscillator fail. t_{CQOUT} specifies the maximum time before switching to the internal self clock mode after POR or STOP if a proper oscillation is not detected. The quality check also determines the minimum oscillator start-up time t_{UPOSC} . The device also features a clock monitor. A Clock Monitor Failure is asserted if the frequency of the incoming clock signal is below the Assert Frequency f_{CMFA} .